Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | 10/541,013 | HENDERSON ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,325,904	12-2001	Peeters, John P.	257/414
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-		·	
	G	US-			
	Н	US-			
	Т	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			-

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N			_		•
	0					
	Р					•
	Q					
	R					·
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U	Lal et al., "Multimodal Atomic Force Microscopy: Biological Imaging Using Atomic Force Microscopy Combined with Light Fluorescence and Confocal Microsopies and Electrophysiologic Recording", International Journal of Imaging Systems and Technology, Vol. 8, 293-300 (1997).					
	٧	Tamayo et al., "Chemical sensors and biosensors in liquid environment based on microcantilevers with amplified quality factor", Ultramicroscopy) (2001) 1-7.					
	w	Yan et al., "A general microcantilever surface modification using a multilayer for biospecific recognition", Organic and Biomolecular Chemistry, available on-line (2002).					
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.